

Search Notes

Application/Control No.

10/649,351

Examiner

Ha T. Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2812

SEARCHED

Class	Subclass	Date	Examiner
Updated	search	7/5/2005	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR